

THC63LVD104A

90MHz 30Bits COLOR LVDS Receiver

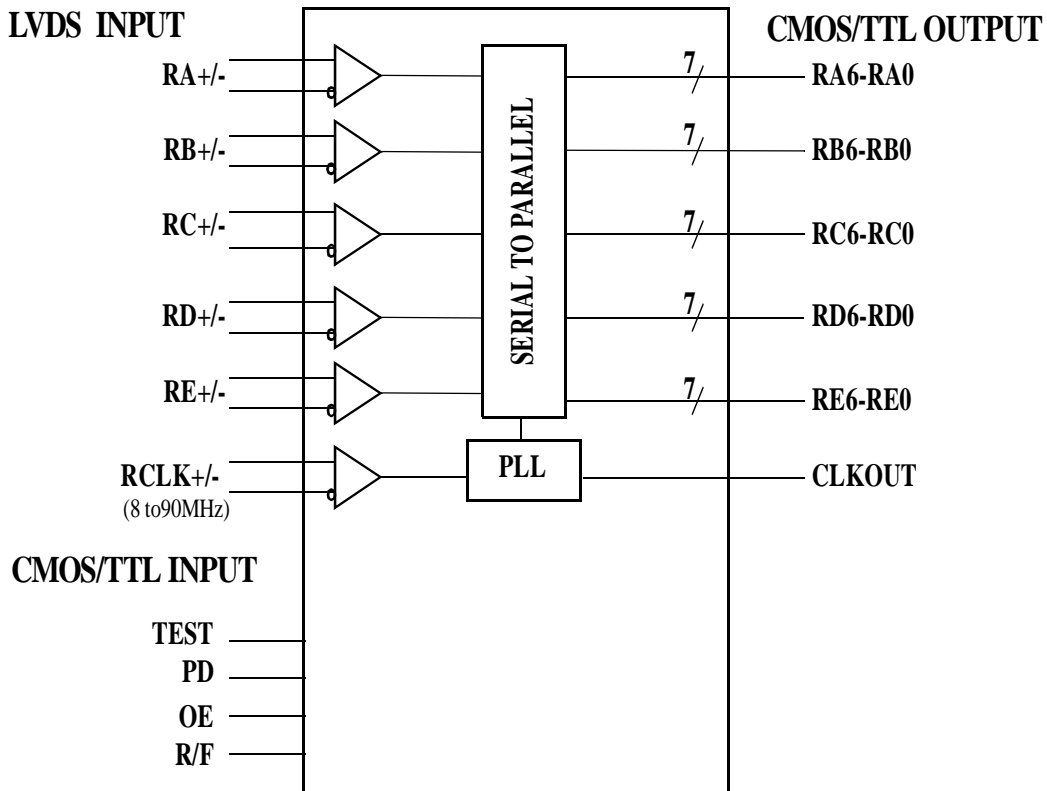
General Description

The THC63LVD104A receiver is designed to support pixel data transmission between Host and Flat Panel Display from NTSC up to WXGA resolutions. The THC63LVD104A converts the LVDS data streams back into 35bits of CMOS/TTL data with rising edge or falling edge clock for convenient with a variety of LCD panel controllers. At a transmit clock frequency of 90MHz, 30bits of RGB data and 5bits of timing and control data (HSYNC, VSYNC, DE, CNTL1, CNTL2) are transmitted at an effective rate of 630Mbps per LVDS channel. Using a 90MHz clock, the data throughput is 394Mbytes per second.

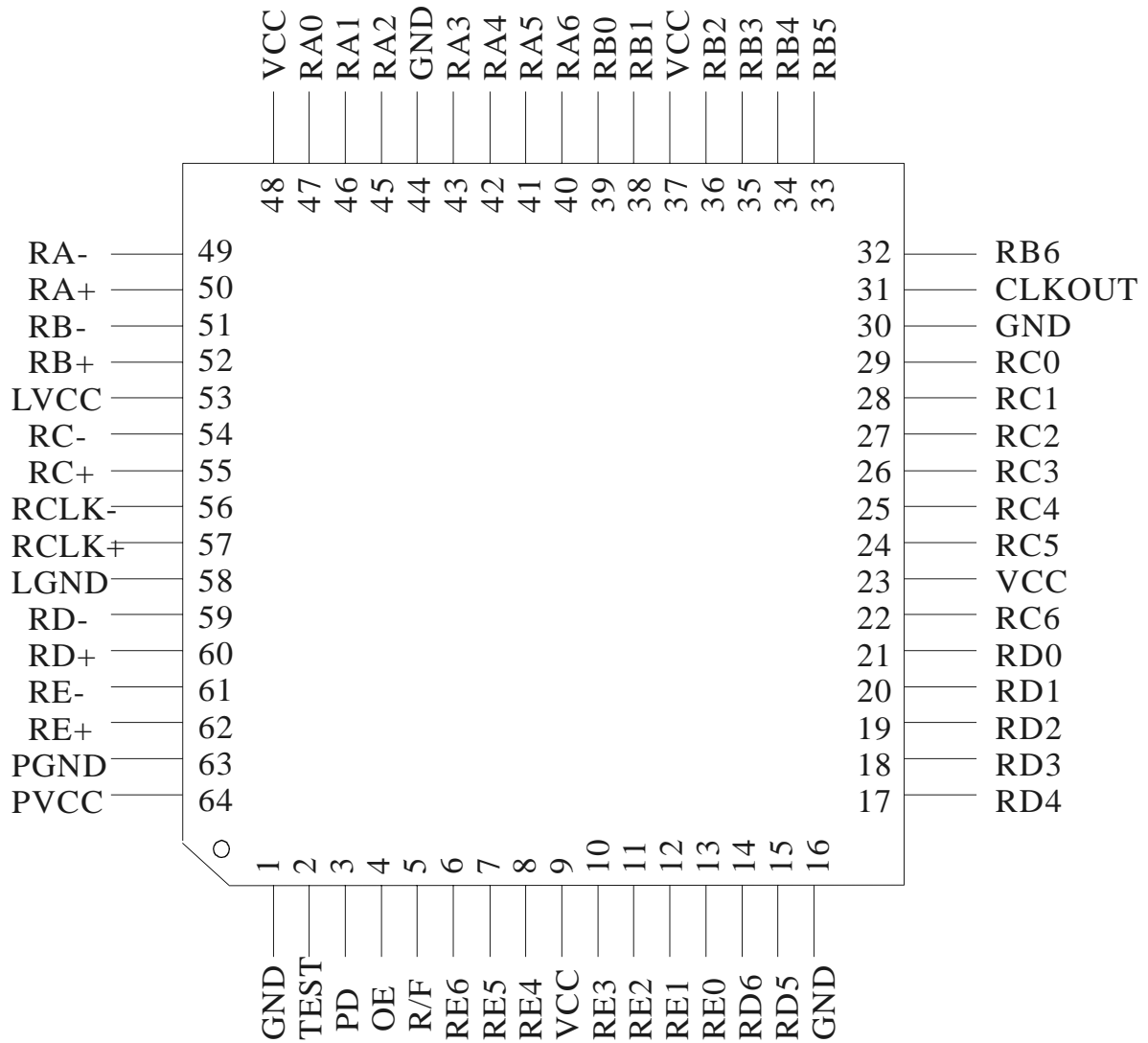
Features

- Wide dot clock range: 8-90MHz suited for NTSC, VGA, SVGA, XGA, and WXGA
- PLL requires no external components
- 50% output clock duty cycle
- TTL clock edge programmable
- Power down mode
- Low power single 3.3V CMOS design
- 64pin TQFP
- Backward compatible with THC63LVDF64x (18bits) / F84x(24bits)

Block Diagram



Pin Out



Pin Description

| Pin Name | Pin # | Type | Description |
|--------------|----------------------|---------|--|
| RA+, RA- | 50, 49 | LVDS IN | LVDS Data In. |
| RB+, RB- | 52, 51 | LVDS IN | |
| RC+, RC- | 55, 54 | LVDS IN | |
| RD+, RD- | 60, 59 | LVDS IN | |
| RE+,RE- | 62, 61 | LVDS IN | |
| RCLK+, RCLK- | 57, 56 | LVDS IN | LVDS Clock In. |
| RA6 ~ RA0 | 40,41,42,43,45,46,47 | OUT | CMOS/TTL Data Outputs. |
| RB6 ~ RB0 | 32,33,34,35,36,38,39 | OUT | |
| RC6 ~ RC0 | 22,24,25,26,27,28,29 | OUT | |
| RD6 ~ RD0 | 14,15,17,18,19,20,21 | OUT | |
| RE6 ~ RE0 | 6,7,8,10,11,12,13 | OUT | |
| TEST | 2 | IN | Test pin, must be "L" for normal operation. |
| PD | 3 | IN | H: Normal operation, L: Power down (all outputs are "L") |
| OE | 4 | IN | H: Output enable (Normal operation). L: Output disable (all outputs are Hi-Z) |
| R/F | 5 | IN | Output Clock Triggering Edge Select. H: Rising edge, L: Falling edge |
| VCC | 9,23,37,48 | Power | Power Supply Pins for TTL outputs and digital circuitry. |
| CLKOUT | 31 | OUT | Clock out. |
| GND | 1,16,30,44 | Ground | Ground Pins for TTL outputs and digital circuitry. |
| LVCC | 53 | Power | Power Supply Pin for LVDS inputs. |
| LGND | 58 | Ground | Ground Pin for LVDS inputs. |
| PVCC | 64 | Power | Power Supply Pin for PLL circuitry. |
| PGND | 63 | Ground | Ground Pin for PLL circuitry. |

| PD | R/F | OE | Data Outputs (Rxn) | CLKOUT |
|----|-----|----|--------------------|---|
| 0 | 0 | 0 | Hi-Z | Hi-Z |
| 0 | 0 | 1 | All 0 | Fixed Low |
| 0 | 1 | 0 | Hi-Z | Hi-Z |
| 0 | 1 | 1 | All 0 | Fixed Low |
| 1 | 0 | 0 | Hi-Z | Hi-Z |
| 1 | 0 | 1 | Data Out | It latches output data on falling edge. |
| 1 | 1 | 0 | Hi-Z | Hi-Z |
| 1 | 1 | 1 | Data Out | It latches output data on rising edge. |

** Rxn

x = A,B,C,D,E

n = 0,1,2,3,4,5,6

Absolute Maximum Ratings ¹

| | |
|----------------------------------|-----------------------------|
| Supply Voltage (V_{CC}) | -0.3V ~ +4.0V |
| CMOS/TTL Input Voltage | -0.3V ~ ($V_{CC} + 0.3V$) |
| CMOS/TTL Output Voltage | -0.3V ~ ($V_{CC} + 0.3V$) |
| LVDS Receiver Input Voltage | -0.3V ~ ($V_{CC} + 0.3V$) |
| Output Current | -30mA ~ 30mA |
| Junction Temperature | +125°C |
| Storage Temperature Range | -55°C ~ +125°C |
| Resistance to soldering heat | +260°C / 10sec |
| Maximum Power Dissipation @+25°C | 1.0W |

Electrical Characteristics

CMOS/TTL DC Specifications

 $V_{CC} = 3.0V \sim 3.6V, T_a = 0^\circ C \sim +70^\circ C$

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Units |
|-----------|---------------------------|---|------|------|----------|---------|
| V_{IH} | High Level Input Voltage | | 2.0 | | V_{CC} | V |
| V_{IL} | Low Level Input Voltage | | GND | | 0.8 | V |
| V_{OH} | High Level Output Voltage | $I_{OH} = -4mA$ (data) $I_{OH} = -8mA$ (clock) | 2.4 | | | V |
| V_{OL} | Low Level Output Voltage | $I_{OL} = 4mA$ (data) $I_{OL} = 8mA$ (clock) | | | 0.4 | V |
| I_{INC} | Input Current | $0V \leq V_{IN} \leq V_{CC}$ | | | ± 10 | μA |

LVDS Receiver DC Specifications

 $V_{CC} = 3.0V \sim 3.6V, T_a = 0^\circ C \sim +70^\circ C$

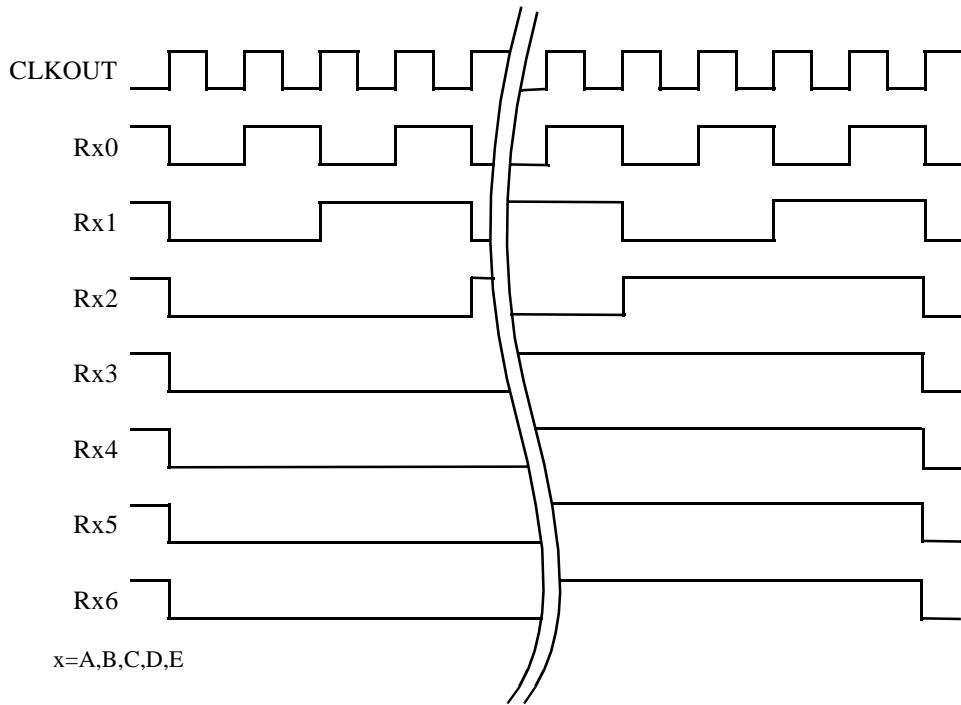
| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Units |
|-----------|-----------------------------------|---|------|------|----------|---------|
| V_{TH} | Differential Input High Threshold | $V_{OC} = 1.2V$ | | | 100 | mV |
| V_{TL} | Differential Input Low Threshold | $V_{OC} = 1.2V$ | -100 | | | mV |
| I_{INL} | Input Current | $V_{IN} = 2.4V / 0V$ $V_{CC} = 3.6V$ | | | ± 20 | μA |

1. "Absolute Maximum Ratings" are those valued beyond which the safety of the device can not be guaranteed. They are not meant to imply that the device should be operated at these limits. The tables of "Electrical Characteristics" specify conditions for device operation.

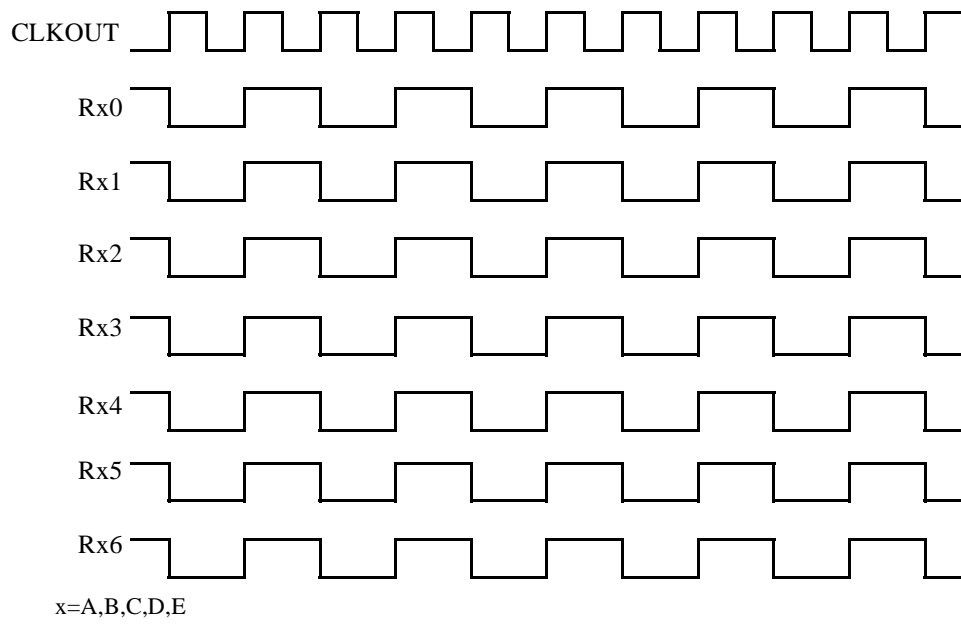
Supply Current $V_{CC} = 3.0V \sim 3.6V$, $T_a = 0^{\circ}C \sim +70^{\circ}C$

| Symbol | Parameter | Conditions | | Typ. | Max. | Units |
|------------|---|----------------------|---------------------|------|------|---------|
| I_{RCCG} | Receiver Supply Current (Gray Scale Pattern) | $f_{CLKOUT} = 90MHz$ | CL=8pF, Vcc=3.3V | 70 | | mA |
| I_{RCCW} | Receiver Supply Current (Checker Pattern) | $f_{CLKOUT} = 90MHz$ | CL=8pF, Vcc=3.3V | 112 | | mA |
| I_{RCCS} | Receiver Power Down Supply Current | PD = L | | | 10 | μA |

Incremental Pattern(Gray Scale)



Toggle Pattern(Checker)



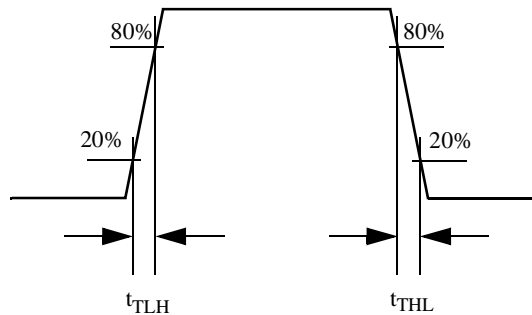
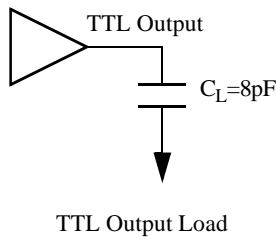
Switching Characteristics

V_{CC} = 3.0V ~ 3.6V, Ta = 0°C ~ +70°C

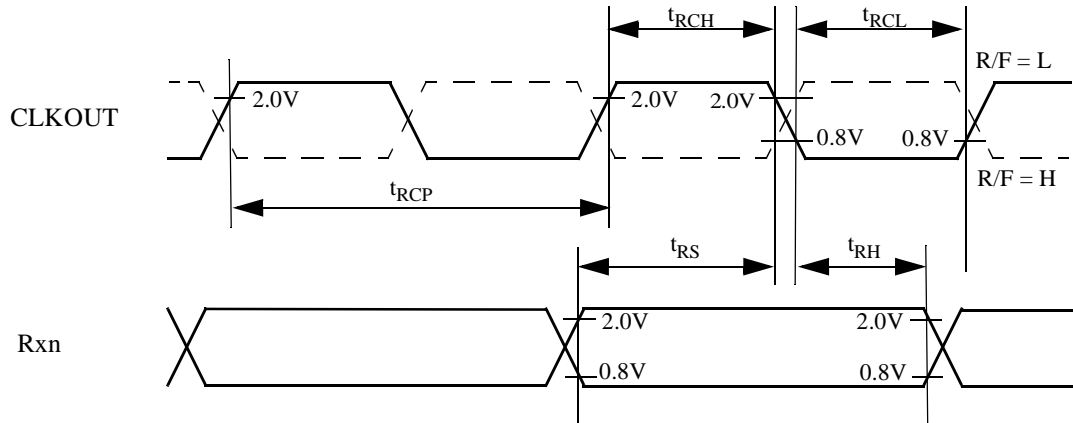
| Symbol | Parameter | Min. | Typ. | Max. | Units |
|-------------------|---------------------------------|------------------------------|-----------------------|------------------------------|-------|
| t _{RCP} | CLKOUT Period | 11.1 | T | 125.0 | ns |
| t _{RCH} | CLKOUT High Time | | $\frac{T-1}{2}$ | | ns |
| t _{RCL} | CLKOUT Low Time | | $\frac{T-1}{2}$ | | ns |
| t _{RS} | TTL Data Setup to CLKOUT | t _{RCP} - 7.0 | | | ns |
| t _{RH} | TTL Data Hold from CLKOUT | 1.0 | | | ns |
| t _{TLH} | TTL Low to High Transition Time | | 1.0 | 2.0 | ns |
| t _{THL} | TTL High to Low Transition Time | | 1.0 | 2.0 | ns |
| t _{RIP1} | Input Data Position0 | -0.25 | 0.0 | +0.25 | ns |
| t _{RIP0} | Input Data Position1 | $\frac{t_{RCIP}}{7} - 0.25$ | $\frac{t_{RCIP}}{7}$ | $\frac{t_{RCIP}}{7} + 0.25$ | ns |
| t _{RIP6} | Input Data Position2 | $2\frac{t_{RCIP}}{7} - 0.25$ | $2\frac{t_{RCIP}}{7}$ | $2\frac{t_{RCIP}}{7} + 0.25$ | ns |
| t _{RIP5} | Input Data Position3 | $3\frac{t_{RCIP}}{7} - 0.25$ | $3\frac{t_{RCIP}}{7}$ | $3\frac{t_{RCIP}}{7} + 0.25$ | ns |
| t _{RIP4} | Input Data Position4 | $4\frac{t_{RCIP}}{7} - 0.25$ | $4\frac{t_{RCIP}}{7}$ | $4\frac{t_{RCIP}}{7} + 0.25$ | ns |
| t _{RIP3} | Input Data Position5 | $5\frac{t_{RCIP}}{7} - 0.25$ | $5\frac{t_{RCIP}}{7}$ | $5\frac{t_{RCIP}}{7} + 0.25$ | ns |
| t _{RIP2} | Input Data Position6 | $6\frac{t_{RCIP}}{7} - 0.25$ | $6\frac{t_{RCIP}}{7}$ | $6\frac{t_{RCIP}}{7} + 0.25$ | ns |
| t _{RPLL} | Phase Lock Loop Set | | | 10.0 | ms |
| t _{RCIP} | CLKIN Period | 11.1 | | 125.0 | ns |

AC Timing Diagrams

TTL Outputs

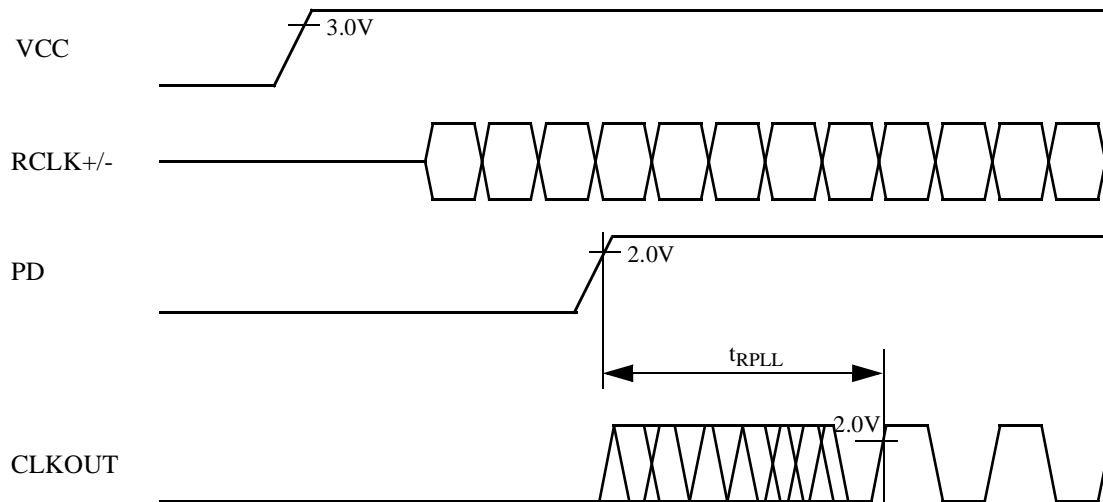


AC Timing Diagrams
TTL Outputs



x = A,B,C,D,E
n = 0,1,2,3,4,5,6

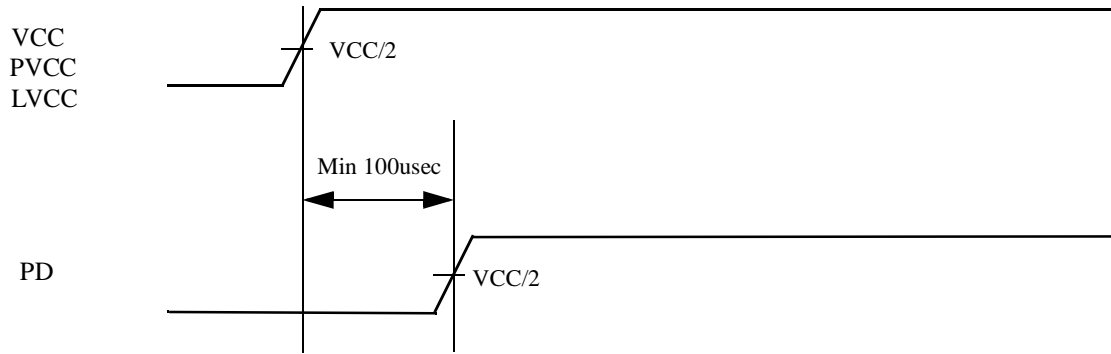
Phase Lock Loop Set Time



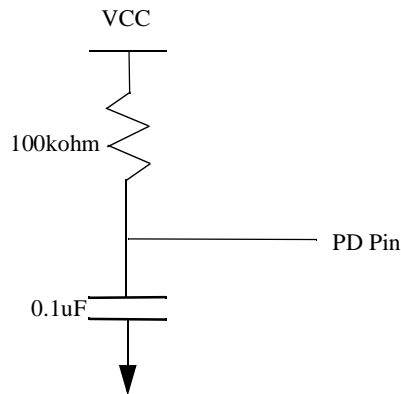
Power Up Sequence

Power Up Sequence must be Sequence1 or Sequence2.

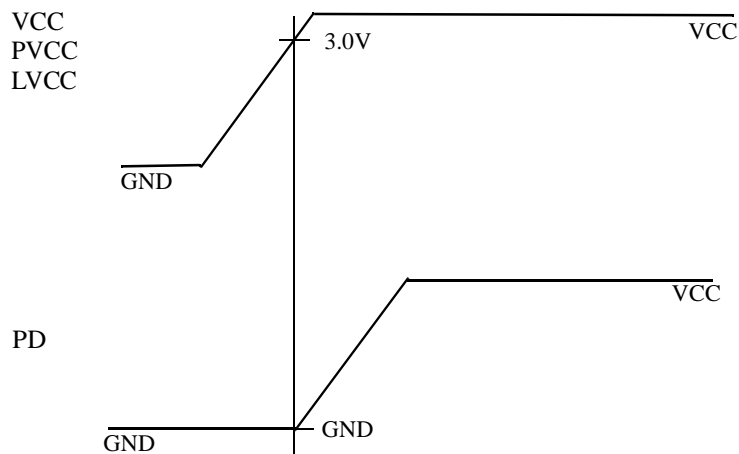
1)Sequence1



Recommended PD Pin Circuit

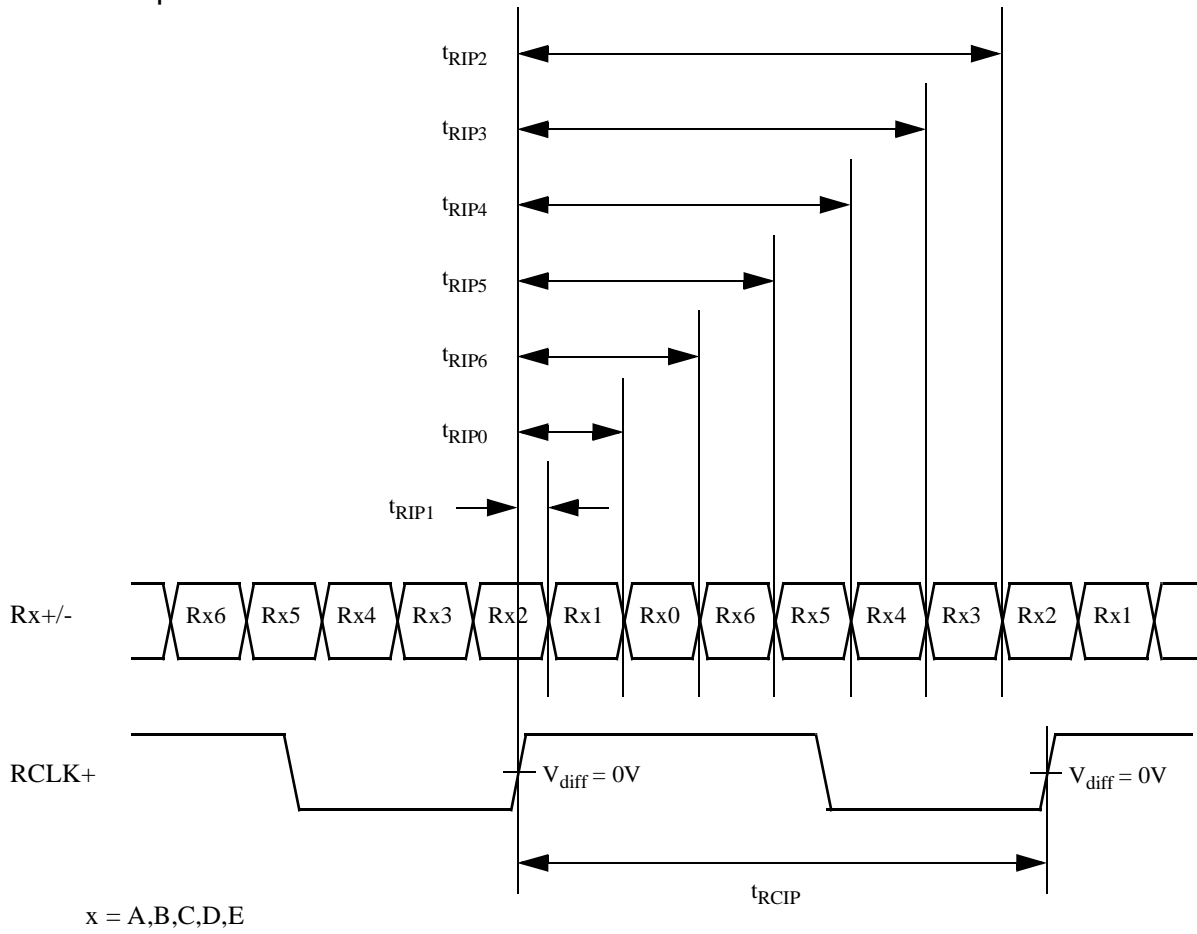


2)Sequence2



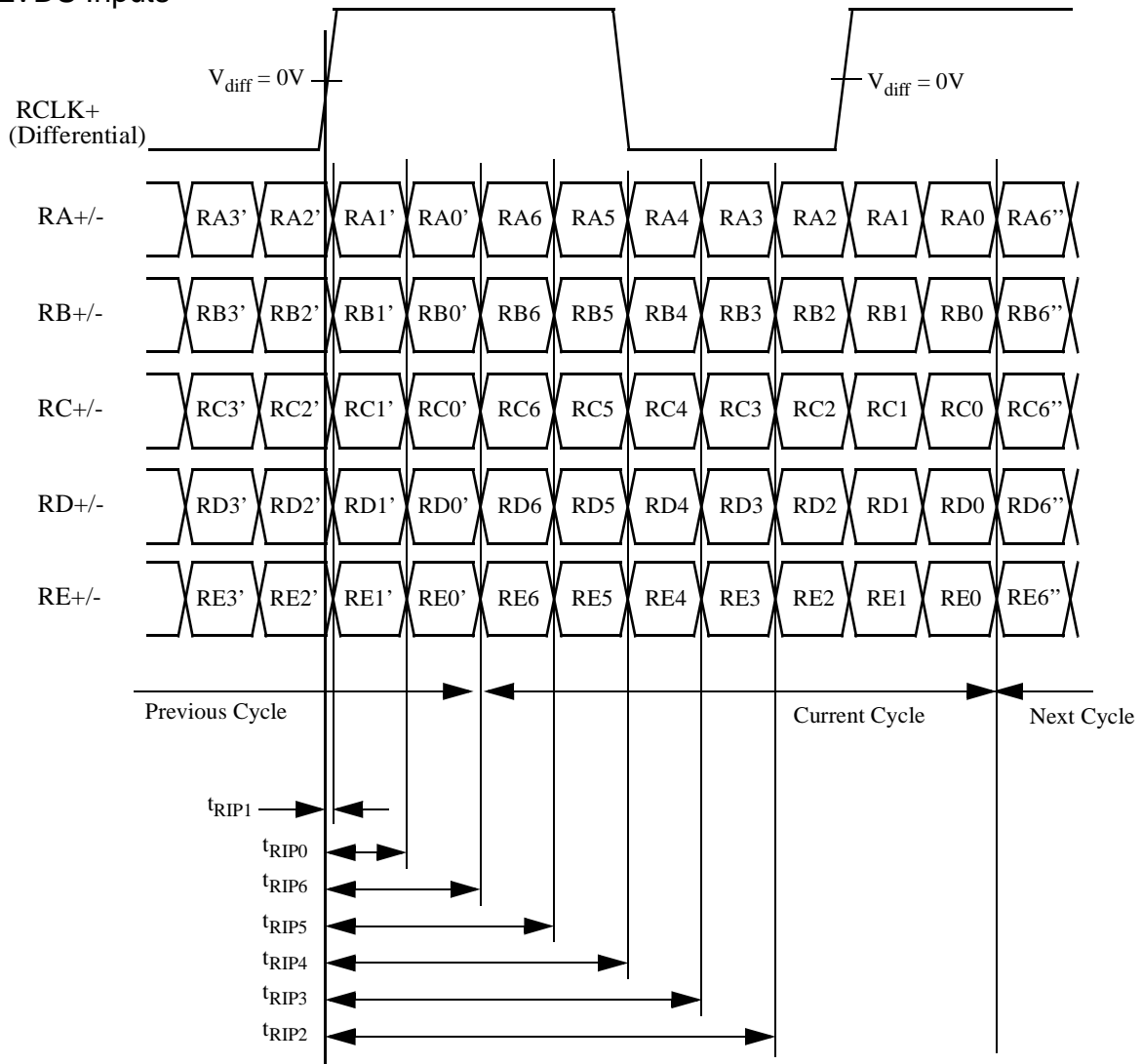
PD pin must be High after VCC voltage is 3.0V.

AC Timing Diagrams
LVDS Inputs

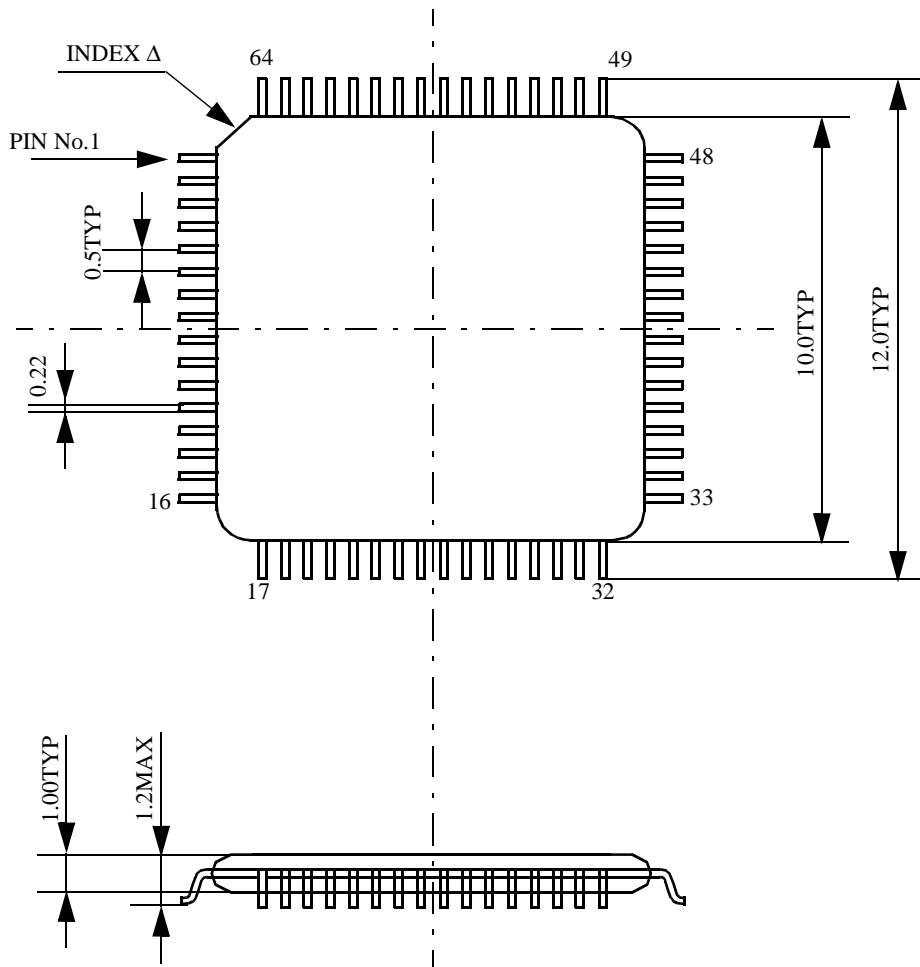


AC Timing Diagrams

LVDS Inputs



Package



UNITS: mm

Notes to Users:

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8. This technical document was provisionally created during development of THC63LVD104A, so there is a possibility of differences between it and the product's final specifications. When designing circuits using THC63LVD104A, be sure to refer to the final technical documents.

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